

WEST**Searches for User *jhollington* (Count = 10138)****Queries 10089 through 10138.**

S #	Updt	Database	Query	Time	Comment
<u>S10138</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	((wafer marking)and semiconductor) and defect	2003-09-09 13:28:17	
<u>S10137</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	((wafer marking)and semiconductor) and map	2003-09-09 12:16:20	
<u>S10136</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	(wafer marking) and semiconductor defect	2003-09-09 12:14:01	
<u>S10135</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	(wafer marking) and semiconductor	2003-09-09 12:13:41	
<u>S10134</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	(wafer marking) and ((324/\$)!CCLS.)	2003-09-09 11:38:44	
<u>S10133</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	wafer marking	2003-09-09 11:36:21	
<u>S10132</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	wafer defect mark\$	2003-09-09 11:34:42	
<u>S10131</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	(wafer defect) and marking	2003-09-09 11:01:39	
<u>S10130</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	wafer defect	2003-09-09 11:00:39	
<u>S10129</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	6448506.pn. and copper	2003-09-05 15:28:58	
<u>S10128</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	6448506.pn. and etch\$	2003-09-05 15:25:40	
<u>S10127</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	6448506.pn. and mask	2003-09-05 15:23:04	
<u>S10126</u>	<u>U</u>	USPT,PGPB,JPAB,EPAB,DWPI,TDBD	((probe same mask)and photoresist)	2003-09-05 14:15:54	

For 10/068152